

<b>Notice of References Cited</b>	Application/Control No. 10/647,419	Applicant(s)/Patent Under Reexamination YOSHIHIRO YAZAWA ET AL	
	Examiner Deborah Yee	Art Unit 1742	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,645,318	11-2003	Takahashi et al.	148/325
	B	US-5,859,095	01-1999	Moyle et al.	523/402
	C	US-5,677,268	10-1997	Omosako et al.	508/171
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
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	S					
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**NON-PATENT DOCUMENTS**

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